



# FQD19N10 / FQU19N10

### 100V N-Channel MOSFET

#### **General Description**

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

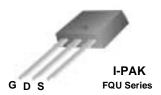
This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for low voltage applications such as audio amplifier, high efficiency switching DC/DC converters, and DC motor control.

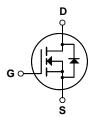
#### **Features**

- 15.6A, 100V,  $R_{DS(on)}$  = 0.1 $\Omega$  @V<sub>GS</sub> = 10 V Low gate charge ( typical 19 nC)
- Low Crss (typical 32 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability
- · RoHS Compliant









# Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		FQD19N10 / FQU19N10	Units
V <sub>DSS</sub>	Drain-Source Voltage		100	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C) - Continuous (T <sub>C</sub> = 100°C)		15.6	Α
			9.8	А
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	62.4	А
V <sub>GSS</sub>	Gate-Source Voltage		± 25	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	220	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	15.6	А
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	5.0	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	6.0	V/ns
P <sub>D</sub>	Power Dissipation (T <sub>A</sub> = 25°C) *		2.5	W
	Power Dissipation (T <sub>C</sub> = 25°C)		50	W
	- Derate above 25°C		0.4	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
T <sub>L</sub>	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

### **Thermal Characteristics**

\* When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		2.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		110	°C/W

Symbol	Parameter Test Conditions		Min	Тур	Max	Units
Off Cha	aracteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100			V
$\Delta BV_{DSS}$ / $\Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$ , Referenced to 25°C		0.1		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V			1	μА
		V <sub>DS</sub> = 80 V, T <sub>C</sub> = 125°C			10	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 25 V, V <sub>DS</sub> = 0 V			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = -25 V, V <sub>DS</sub> = 0 V			-100	nA
On Cha	racteristics					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	2.0		4.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 7.8 A		0.078	0.1	Ω
9 <sub>FS</sub>	Forward Transconductance	uctance $V_{DS} = 40 \text{ V}, I_{D} = 7.8 \text{ A}$ (Note 4)		11		S
C <sub>iss</sub>	Input Capacitance Output Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz		600 165	780 215	pF pF
C <sub>oss</sub>	Output Capacitance			165	215	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			32	40	pF
Switchi	ing Characteristics					
t <sub>d(on)</sub>	Turn-On Delay Time	V 50 V L 40 A		7.5	25	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DD} = 50 \text{ V}, I_{D} = 19 \text{ A},$ $R_{G} = 25 \Omega$		150	310	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	1 NG - 20 32		20	50	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4, 5)		65	140	ns
Qg	Total Gate Charge	V <sub>DS</sub> = 80 V, I <sub>D</sub> = 19 A,		19	25	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 10 V (Note 4, 5)		3.9		nC
Q <sub>gd</sub>	Gate-Drain Charge			9.0		nC
	Source Diode Characteristics an				45.0	Δ.
l <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current  Maximum Pulsed Drain-Source Diode Forward Current				15.6	A
I <sub>SM</sub>					62.4	V
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 15.6 \text{ A}$ $V_{GS} = 0 \text{ V}, I_S = 19 \text{ A},$		78	1.5	
t <sub>rr</sub>	Reverse Recovery Time	$dI_F / dt = 100 \text{ A/}\mu\text{s}$ (Note 4)		_		ns nC
Q <sub>rr</sub>	Reverse Recovery Charge	uif / ut = 100 A/μ5 (1000 4)		200		n

- **Notes:**1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 1.35mH, I<sub>AS</sub> = 15.6A, V<sub>DD</sub> = 25V, R<sub>G</sub> = 25 Ω, Starting T<sub>J</sub> = 25°C 3. I<sub>SD</sub>  $\leq$  19A, di/dt  $\leq$  300A/μs, V<sub>DD</sub>  $\leq$  BV<sub>DSS</sub>, Starting T<sub>J</sub> = 25°C 4. Pulse Test : Pulse width  $\leq$  300μs, Duty cycle  $\leq$  2% 5. Essentially independent of operating temperature

# **Typical Characteristics**

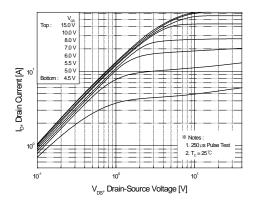


Figure 1. On-Region Characteristics

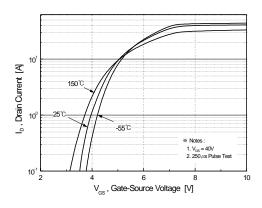


Figure 2. Transfer Characteristics

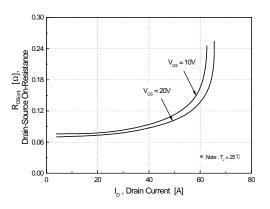


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

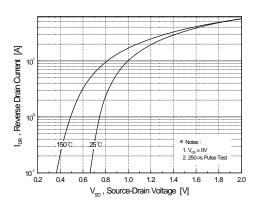


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

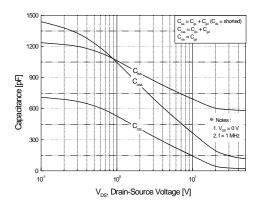


Figure 5. Capacitance Characteristics

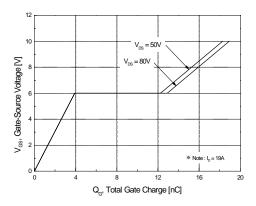
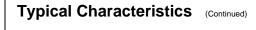


Figure 6. Gate Charge Characteristics



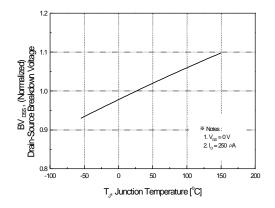
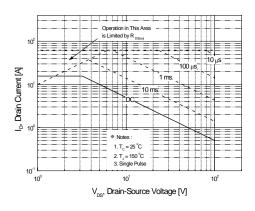


Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



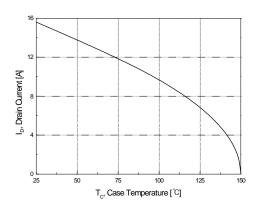


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

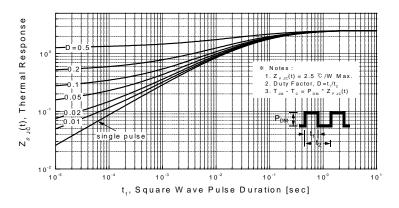
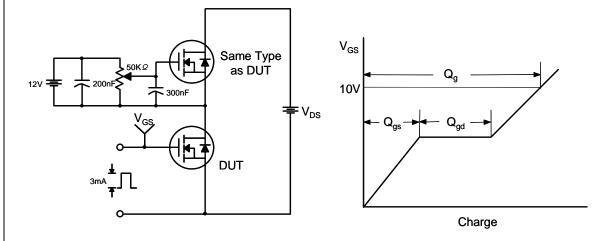


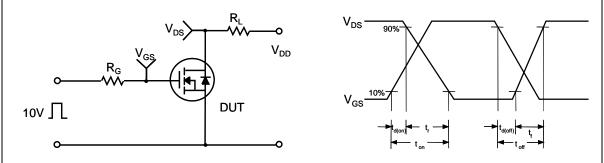
Figure 11. Transient Thermal Response Curve

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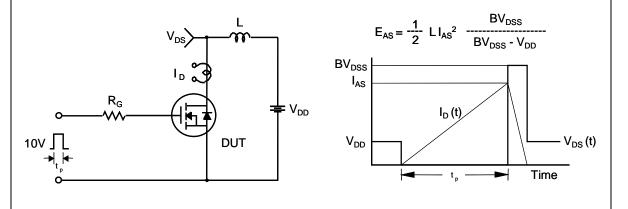
## **Gate Charge Test Circuit & Waveform**



### **Resistive Switching Test Circuit & Waveforms**

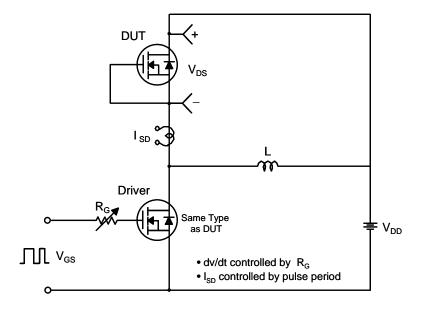


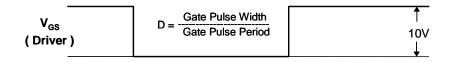
### **Unclamped Inductive Switching Test Circuit & Waveforms**

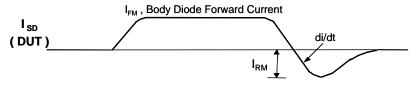


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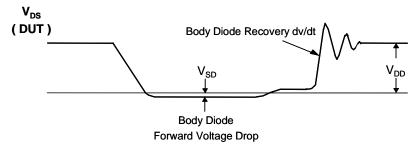
#### Peak Diode Recovery dv/dt Test Circuit & Waveforms







Body Diode Reverse Current

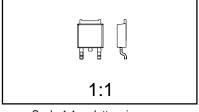


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## **Package Dimensions**

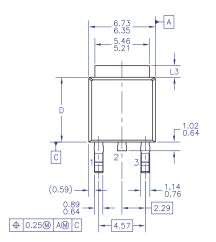
# TO-252 (DPAK) (FS PKG Code 36)

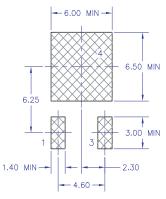




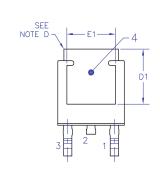
Scale 1:1 on letter size paper Dimensions shown below are in: millimeters

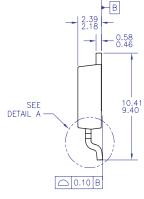
Part Weight per unit (gram): 0.33

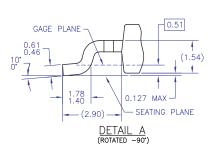




LAND PATTERN RECOMMENDATION







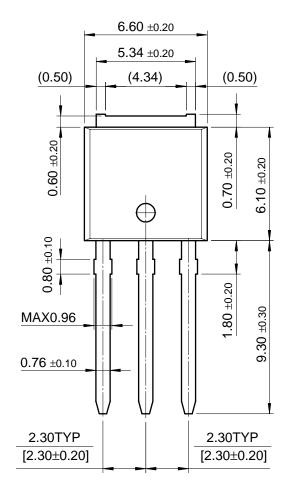
NOTES: UNLESS OTHERWISE SPECIFIED

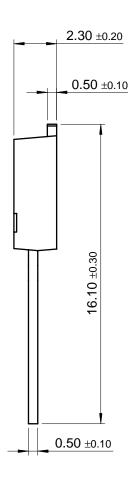
- A) B)
- ALL DIMENSIONS ARE IN MILLIMETERS.
  THIS PACKAGE CONFORMS TO JEDEC, TO-252,
  ISSUE C, VARIATION AA & AB, DATED NOV. 1999.
- DIMENSIONING AND TOLERANCING PER
  ASME Y14.5M-1994.
  HEAT SINK TOP EDGE COULD BE IN CHAMFERED
  CORNERS OR EDGE PROTRUSION.
  DIMENSIONS L3,D,E1&D1 TABLE:

	OPTION AA	OPTION AB
L3	0.89-1.27	1.52-2.03
D	5.97-6.22	5.33-5.59
E1	4.32 MIN	3.81 MIN
D1	5.21 MIN	4.57 MIN



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No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
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